

# Data Deposition, Metadata, ISO Standards, Calibration Standards, Publication Standards for Small-Angle Scattering

*– a personal perspective on some ongoing developments*

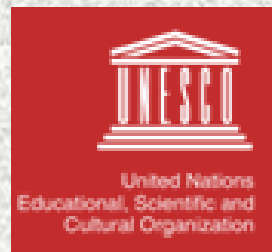
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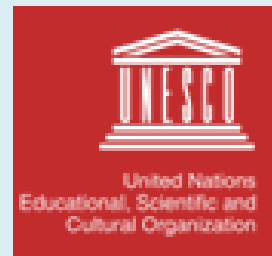
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***All canSAS efforts of interest to, and encouraged by, SAS Commission!***

# International Year of Crystallography (IYCr 2014):



- (1) IYCr presence at international symposia, and a record number of SAS microsymbosia at 2014 IUCr Congress in Montreal.
- (2) Chapter on "Disordered and Heterogeneous Materials" for new International Crystallography Table H – *out November 2015*.
- (3) Guidelines issued in open letter to major research journal editors regarding publication standards for Biological SAS papers.
- (4) SAS Commission web-page revised and linked with "SAS Portal".
- (5) Online SAS2012 Special Issue published February 2014 in the *Journal of Applied Crystallography*. Similar plan for SAS 2015.
- (6) NIST SAXS intensity calibration reference material in 2015.
- (7) ISO standard on SAXS-based particle size in 2015.



# SAS Derived Envelopes for Biomolecules in PDB

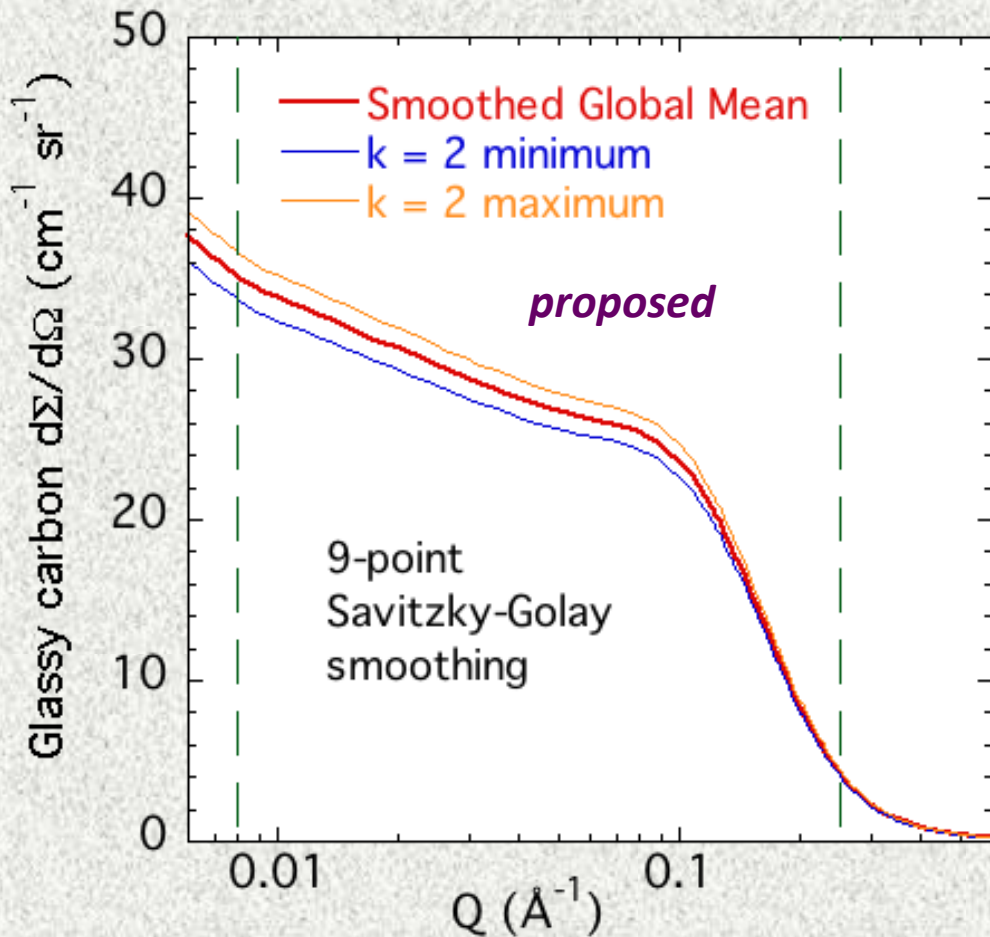
- **World-wide Protein Data Bank (wwPDB) Small-Angle Scattering Task Force (SASStf) –**  
(<http://www.wwpdb.org/workshop/sasTaskForce.html>).
- **Draft publication guidelines: structural modeling of SAS data from biomolecules in solution –**  
(<http://journals.iucr.org/d/issues/2012/02/00/me0456/index.html>).  
Also see: *Acta Cryst. D* (Jacques *et al.*, 2012) and:  
<http://journals.iucr.org/d/issues/2012/06/00/be5200/index.html>.
- **Letter sent on behalf of CSAS to editors of relevant journals indicating publication guidelines –**  
as set out in: *Structure* (Trewhella *et al.*, 2013), and at:  
<http://www.cell.com/structure/abstract/S0969-2126%2813%2900150-0>.

**SAS derived envelopes allowed in PDB if requirements met.**

# NIST Standard Reference Material

## SRM 3600 – *Draft*

### Glassy Carbon Calibration Curve



### SAXS intensity calibration standard:

- Primary calibration using APS USAXS – *with Jan Ilavsky;*
- Based on glassy carbon;
- Certified for SAXS in  $Q$ -range from  $0.008 \text{ \AA}^{-1}$  to  $0.25 \text{ \AA}^{-1}$ ;
- Validated with SANS at NCNR;
- Calibration curve will be provided with ( $k = 2$ ) 95 % confidence uncertainty bands;
- Primarily for industry.

# International Organization for Standardization (ISO)

## Best Practice Standard for SAXS

**ISO: Technical Committee TC 24:**

*Particle characterization including sieving:*

**Subcommittee SC 4:** *Particle characterization*



**ISO/FDIS 17867:**

***Particle size analysis — Small-angle X-ray scattering***

*– initiated by Alan Rawle (Malvern Instr.), who taught himself SAS in process!*

– describes best practice for SAXS measurements and data analysis for SAXS determination of nanoparticle size.

Developed over several years and released in 2015, this is a basic best practice standard for SAXS-based determination of particle size, and is the first ISO standard for small-angle scattering. It is primarily aimed at industry.



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***Data deposition and validation issues are beginning to cross our desks!  
e.g., IUCr Diffraction Data Deposition Working Group (DDDWG)***

# Some Data Issues in Our Future

- U.S. Government funding agencies (NSF, DOE, etc.) are requiring data management plans as condition for funded research.
  - Data must be safeguarded & may ultimately be made available.
  - This is becoming an international trend. ***What does it mean?***
- 
- ❑ Raw data (instrument-dependent) are not very useful without a lot of explanation of how data were obtained.
  - ❑ Reduced data (instrument-independent) are potentially much more useful, together with modeled / fitted data – ***but guidance needed!***
  - ❑ Different researchers may ultimately get results and publish using previous researchers' data. Credit to be divided between those obtaining data, and those developing new results from data.
  - ❑ ***Especially for a field like SAS, metadata will be critical!***  
– ***IUCr Executive asking Commissions for metadata requirements.***



# Some Proposed Metadata Needs for SAS

– A.J. Allen with Fan Zhang and others, 2015

## Common contents:

- Descriptive title of experiment
- Names of experimenters
- Instrument name and location
- Type of source:  
*X-ray tube, rotating anode or synchrotron; neutron reactor or pulsed source*
- X-ray energy/wavelength or neutron wavelength
- Estimated wavelength spread
- Types of attenuator and amount of attenuation for transmissions etc.
- Sample identifier, nature of sample, preparation, history, etc.
- Sample thickness
- Sample chamber and sample environment (temperature, pressure, pH, etc.)
- Measurement duration and time stamp (start, end, etc.)
- File location
- Data reduction package
- Data analysis / modeling package

# Proposed Metadata Needs for SAS (continued)

## Pinhole-collimated SAXS and SANS:

- Horizontal & vertical beam defining slit apertures (or diameter)
- Horizontal & vertical guard slit apertures (or diameter)
- Source-to-sample distance collimation details
- Type, number, thicknesses of X-ray or neutron windows in beam path
- Quality of vacuum in the beam path; amount of ambient beam path
- Type of 2D detector (& relevant set-up parameters, readout mode, etc.)
- Detector horizontal & vertical pixel sizes and binning
- Sample-to-detector distance & collimation details
- Detector tilt angle & offset from incident beam path
- Horizontal & vertical beam center coordinates (in pixels)
- Polarization correction factor
- $Q$  calibration & intensity calibration standard methods & mode
- Incident & transmitted beam intensities, sample transmission
- SAS measurement / exposure / image acquisition times
- Location of flat field / detector sensitivity 2D correction file
- Location of dark field / electronic background 2D correction file
- Location of 2D detector mask file applied

# Proposed Metadata Needs for SAS (continued)

## ***Additional for Bense-Hart USAXS and USANS:***

- 1D or 2D collimation (for USAXS) & pre-monochromator (for USANS)
- Incident beam collimating monochromator crystal type & reflection
- Incident beam number of collimating monochromator reflections
- Incident beam transverse collimating crystal, reflection, number (if any)
- Scattered beam transverse analyzer crystal, reflection, number (if any)
- Scattered beam analyzer crystal type & reflection
- Scattered beam number of analyzer reflections
- Darwin curve FWHM width in  $\text{\AA}^{-1}$  or  $\text{nm}^{-1}$  ( $Q$  units) &  $Q$  resolution
- Primary beam intensity at  $Q = 0$  without / with sample; sample transmission
- Pre-sample ion chamber / fission monitor details & readout
- Main USAXS or USANS detector type; readout mode, gains, backgrounds
- Main detector active area & dimensions
- Sample-to-analyzer & sample-to-detector distances; slit-length in  $Q$  (1D)
- Angular offset of scan at  $Q = 0$  (especially for USANS)
- Start (negative) and end positions of scan in  $Q$
- Number of data points,  $Q$ -steps & dwell times, or fly-scan parameters
- Other coordinated stage motions (1D or 2D USAXS)



# Other Metadata Considerations

**At least two other SAS configurations have additional detailed metadata requirements:**

- (1) SANS at pulsed neutron sources** – *clearly metadata need to detail neutron time-binning and all associated effects; must be provided in a way that is transparent for deposited data subsequently used by other researchers.*
- (2) GI-SAXS and NS-SANS** – *details of grazing angle incident geometry & collimation, critical angle information, slit dimensions, sample length along beam, substrate details, etc., need to be included in the metadata.*
- (3) Also: magnetic SANS, SE-SANS, anomalous SAXS, etc.**

**It is critical that all deposited data have corresponding, comprehensive metadata tightly attached:**

- (1) Good metadata will reduce incidence of data fraud.
- (2) Good metadata should ensure deposited data are not abused (accidentally or purposefully) in subsequent use by others.
- (3) Good metadata will lead naturally to improved publication standards.

# Concluding Comments and Suggestion

- (1) In a future world where SAS data supporting publications are deposited and available, metadata, best-practice standards, common data formats, standard reference materials, and publication standards, will become *highly-interrelated* issues.
- (2) Good dedicated SAS researchers probably do not need the infrastructure emerging to support these issues, but will use it!
- (3) Others who seek to employ SAS methods as a tool *will* need the infrastructure; and the whole SAS field / profession can be put on *significantly* firmer ground if things are done well.
- (4) While all of the above issues need work in parallel, metadata issues are probably the most urgent for impending data deposition.

**Should *canSAS* and other activities be configured into task forces charged with working / reporting at the triennial SAS Conferences?**